

## **MOSFET**

### 600V CoolMOS™ SJ S7TA Power Device

CoolMOS™ S7TA enables the best price performance for low-frequency switching applications. The embedded temperature sensor increases junction temperature sensing accuracy and robustness while keeping an easy and seamless implementation. CoolMOS™ S7TA is optimized for "static switching" and high current applications. The new temperature sensor enhances S7A features, allowing the best possible utilization of the power transistor.

# Features

- Optimized price performance in low-frequency switching applications
- · High pulse current capability
- Seamless diagnostics at lowest system cost
- Temperature sense feature for protection and optimized thermal device utilization

#### **Benefits**

- Reduction of external sensing elements, hence a more compact design compared to electromechanical devices
- Increased system performance
- · Minimized conduction losses (reduce heat sink size)
- · More reliability and longer system lifetime
- Shock & Vibration resistance; No contact arcing or bouncing

### Potential applications

- Circuit breakers (HV eDisconnect switch, DC and AC low frequency switch, HV eFuse, on-board charger)
- · Line rectification in high-power/performance applications

#### **Product validation**

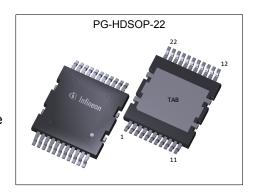
Qualified according to AEC Q101

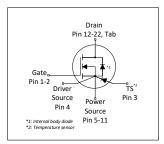
Please note: The source and sense source pins are not exchangeable. Their exchange might lead to malfunction. For paralleling 4pin MOSFET devices the placement of the gate resistor is generally recommended to be on the Driver Source instead of the Gate. For production part approval process (PPAP) release we propose to share application related information during an early design phase to avoid delays in PPAP release. Please contact Infineon sales office.



Parameter	Value	Unit				
R <sub>DS(on),max</sub>	22	mΩ				
$Q_{g,typ}$	150	nC				
V <sub>SD</sub>	0.82	V				
Pulsed I <sub>SD</sub> , I <sub>DS</sub>	371	A				
ESD class (HBM)	2	JEDEC AEC Q101				

Type / Ordering Code	Package	Marking	Related Links
IPQC60T022S7A	PG-HDSOP-22	60T022S7	see Appendix A













# 600V CoolMOS™ SJ S7TA Power Device IPQC60T022S7A



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# **600V CoolMOS™ SJ S7TA Power Device** IPQC60T022S7A



1 Maximum ratings at  $T_j = 25$ °C, unless otherwise specified

Table 2 **Maximum MOSFET ratings** 

Developer	Symbol	Values			11!4	Nata / Tank Oam Hittan	
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain current rating <sup>1)</sup>	$I_{D}$	-	-	90 24	А	T <sub>C</sub> =25°C T <sub>C</sub> =140°C	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	-	-	371	Α	T <sub>C</sub> =25°C	
Avalanche energy, single pulse	<b>E</b> AS	-	-	286	mJ	$I_D$ =3.7A; $V_{DD}$ =50V; see table 11	
Avalanche current, single pulse	I <sub>AS</sub>	-	-	3.7	Α	-	
MOSFET dv/dt ruggedness <sup>3)</sup>	dv/dt	-	-	20	V/ns	V <sub>DS</sub> = 0V to 300V	
Gate source voltage (static)	V <sub>GS</sub>	-20	-	20	V	static	
Gate source voltage (dynamic)	V <sub>GS</sub>	-30	-	30	V	AC (f>1 Hz)	
Power dissipation	P <sub>tot</sub>	-	-	416	W	T <sub>C</sub> =25°C	
Storage temperature	T <sub>stg</sub>	-55	-	150	°C	-	
Operating junction temperature <sup>1)</sup>	T <sub>j</sub>	-40	-	150	°C	-	
Extended operating junction temperature	T <sub>j</sub>	150	-	175	°C	≤50 h in the application lifetime	
Mounting torque	-	-	-	n.a.	Ncm	-	
Diode forward current rating	Is	-	-	24	A	T <sub>C</sub> =140°C Current is limited by T <sub>j max</sub> = 150°C; Lower case temp does increase current capability	
Diode pulse current <sup>1)</sup>	I <sub>S,pulse</sub>	-	-	371	Α	T <sub>C</sub> =25°C	
Reverse diode dv/dt <sup>4)</sup>	dv/dt	-	-	5	V/ns	$V_{\rm DS}$ =0 to 300V, $I_{\rm SD}$ <=23A, $T_{\rm j}$ =25°C see table 9	
Maximum diode commutation speed	di <sub>f</sub> /dt	-	-	800	A/μs	s $V_{DS}$ =0 to 300V, $I_{SD}$ <=23A, $T_{j}$ =25° see table 9	
Insulation withstand voltage	V <sub>ISO</sub>	-	-	n.a.	V	-	

 $<sup>^{1)}</sup>$  Please consider the App Note: 600 V CoolMOS  $^{\text{TM}}$  S7 with Temperature Sense for high delta T $_{\text{J}}$  usage  $^{2)}$  Pulse width  $t_{\text{p}}$  limited by  $T_{\text{j,max}}$   $^{3)}$  The dv/dt has to be limited by appropriate gate resistor  $^{4)}$  Identical low side and high side switch

# 600V CoolMOS™ SJ S7TA Power Device





# 2 Thermal characteristics

**Table 3** Thermal characteristics

Damamatan	Oala al	Values			11:4	Nata / Tarak O am distant
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	0.3	°C/W	-
Thermal resistance, junction - ambient	R <sub>thJA</sub>	-	-	62	°C/W	device on PCB, minimal footprint
Thermal resistance, junction - ambient for SMD version		-	45	55	°C/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thickness) copper area. Tap exposed to air. PCB is vertical without air stream cooling.
Soldering temperature, reflow soldering allowed	T <sub>sold</sub>	-	-	260	°C	reflow MSL1

## 600V CoolMOS™ SJ S7TA Power Device IPQC60T022S7A



### **Electrical characteristics**

at T<sub>i</sub>=25°C, unless otherwise specified

#### Table 4 Static characteristics

The CoolMOS<sup>™</sup> mentioned in this datasheet shall not be operated in linear mode. For any questions in this regard, please contact Infineon sales office.

For applications with applied blocking voltage >400V, it is required that the customer

evaluates the impact of cosmic radiation effect in early design phase and contacts the Infineon sales office for the necessary technical support by Infineon

Paramatan.	Cumbal	Values			11	Nata / Task Canalities
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	600	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =1mA
Gate threshold voltage	$V_{(GS)th}$	3.5	4.0	4.5	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=1.43{\rm mA}$
Zero gate voltage drain current	I <sub>DSS</sub>	-	- 50	5	μΑ	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C V <sub>DS</sub> =600V, V <sub>GS</sub> =0V, T <sub>j</sub> =150°C
Gate-source leakage current	I <sub>GSS</sub>	-	-	100	nA	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	0.02 0.046	0.022	Ω	V <sub>GS</sub> =12V, I <sub>D</sub> =23A, T <sub>j</sub> =25°C V <sub>GS</sub> =12V, I <sub>D</sub> =23A, T <sub>j</sub> =150°C
Gate resistance	R <sub>G</sub>	-	0.8	-	Ω	f=1MHz, open drain

**Table 5 Dynamic characteristics**External parasitic elements (PCB layout) influence switching behavior significantly.

Stray inductances and coupling capacitances must be minimized.

For layout recommendations please use provided application notes or contact Infineon sales office.

Paramatan.	Oh a l	Values			11	Nata / Table Open Hillian	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Input capacitance	Ciss	-	5640	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =300V, f=250kHz	
Output capacitance	Coss	-	89	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =300V, f=250kHz	
Effective output capacitance, energy related <sup>1)</sup>	C <sub>o(er)</sub>	-	302	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =0 to 300V	
Effective output capacitance, time related <sup>2)</sup>	C <sub>o(tr)</sub>	-	2677	-	pF	$I_D$ =constant, $V_{GS}$ =0V, $V_{DS}$ =0 to 300V	
Output charge	Qoss	-	803	-	nC	V <sub>GS</sub> =0V, V <sub>DS</sub> =0 to 300V	
Turn-on delay time	$t_{\sf d(on)}$	-	30	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9	
Rise time	t <sub>r</sub>	-	6	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9	
Turn-off delay time	$t_{\sf d(off)}$	-	142	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9	
Fall time	t <sub>f</sub>	-	10	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9	

 $<sup>^{1)}</sup>$   $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 300V  $^{2)}$   $C_{\text{o(tr)}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 300V

# 600V CoolMOS™ SJ S7TA Power Device





 Table 6
 Gate charge characteristics

Develope	Cymbal	Values			11	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q <sub>gs</sub>	-	31	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V
Gate to drain charge	$Q_{gd}$	-	49	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V
Gate charge total	Qg	-	150	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V
Gate plateau voltage	V <sub>plateau</sub>	-	5.4	-	V	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V

### Table 7 Reverse diode characteristics

Dougnatou	Cymahal	Values			11:4	Nata / Task Candition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode forward voltage	V <sub>SD</sub>	-	0.82	-	V	V <sub>GS</sub> =0V, I <sub>F</sub> =23A, T <sub>j</sub> =25°C
Reverse recovery time	t <sub>rr</sub>	-	410	-	ns	$V_R$ =300V, $I_F$ =23A, $di_F/dt$ =100A/ $\mu$ s; see table 8
Reverse recovery charge	Qrr	-	10	-	μC	$V_R$ =300V, $I_F$ =23A, $di_F/dt$ =100A/ $\mu$ s; see table 8
Peak reverse recovery current	I <sub>rrm</sub>	-	48	-	А	$V_R$ =300V, $I_F$ =23A, $di_F/dt$ =100A/ $\mu$ s; see table 8

# **600V CoolMOS™ SJ S7TA Power Device** IPQC60T022S7A



# **4 Temperature Sensor parameters** at $T_j$ =25°C, unless otherwise specified

**Maximum ratings** Table 8

Developedan	Cumb al	Values				Note (Tool Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Repetitive Peak Reverse Voltage	$V_{RRM}$	-	-	15	V	<i>I</i> <sub>R</sub> = 100 μA
Sensor forward current	I <sub>F</sub>	-	-	5	mA	-
Repetitive peak forward current	I <sub>F_pulse</sub>	_	-	25	mA	t <sub>pulse</sub> = 1 ms, T <sub>period</sub> = 10 ms
Non-repetitive peak forward current	I <sub>FSM</sub>		-	1.5 0.2 0.1	A	$T_C$ = 25°C, $t_{pulse}$ = 1 $\mu s$ $T_C$ = 25°C, $t_{pulse}$ = 1 ms $T_C$ = 25°C, $t_{pulse}$ = 1 s
Junction Temperature	T <sub>j</sub>	_	-	185	°C	t < 50h, Sensor only

#### **Electrical characteristics** Table 9

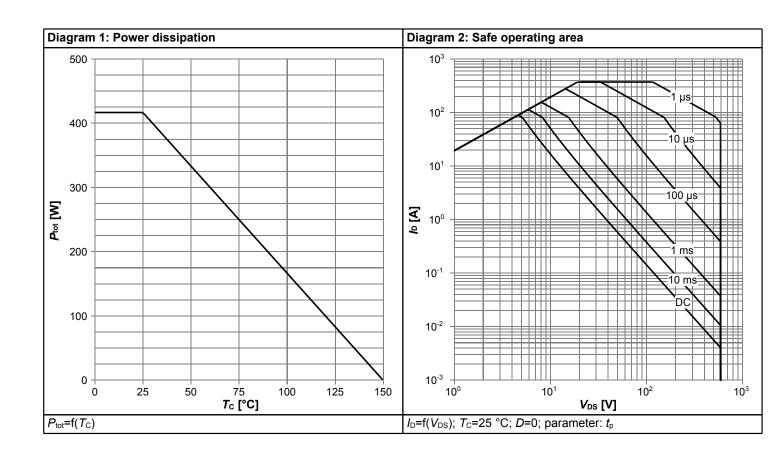
Parameter	Symbol	Values			Unit	Note / Test Condition	
raiailletei	Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition	
Sensor forward voltage <sup>1)</sup>	V <sub>F_25</sub>	1.5601 - - 2.0665	1.6019 1.8103 1.9806 2.0966	-	V	$T_{j} = 25^{\circ}\text{C}, I_{F} = 10 \ \mu\text{A}$ $T_{j} = 25^{\circ}\text{C}, I_{F} = 50 \ \mu\text{A}$ $T_{j} = 25^{\circ}\text{C}, I_{F} = 200 \ \mu\text{A}$ $T_{j} = 25^{\circ}\text{C}, I_{F} = 500 \ \mu\text{A}$	
Sensor forward voltage temperature coefficient	TC	- - -	5.9644 5.5880 5.2287 5.0135	-	mV/K	$\begin{array}{l} 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 10 \ \mu A \\ 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 50 \ \mu A \\ 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 200 \ \mu A \\ 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 500 \ \mu A \\ \end{array}$	
Sensor forward voltage	V <sub>F_175</sub>	-	0.7072 0.9721 1.1963 1.3445	-	V	$T_{j} = 175^{\circ}\text{C}, I_{F} = 10 \mu\text{A}$ $T_{j} = 175^{\circ}\text{C}, I_{F} = 50 \mu\text{A}$ $T_{j} = 175^{\circ}\text{C}, I_{F} = 200 \mu\text{A}$ $T_{j} = 175^{\circ}\text{C}, I_{F} = 500 \mu\text{A}$	
Reverse leakage current	I <sub>R</sub>	-	-	1 20	μA	$V_R = 10V, T_j = 25^{\circ}C$ $V_R = 10V, T_j = 175^{\circ}C$	
Sensor G Capacitance	C <sub>GTS</sub>	-	4.2	-	pF	f = 1 MHz, I <sub>F</sub> = 50 μA	
Sensor Capacitance	C <sub>STS</sub>	-	4.8	-	pF	f = 1 MHz, I <sub>F</sub> = 50 μA	
Anode-Drain Capacitance	C <sub>DTS</sub>	-	0.5	-	pF	f = 1 MHz, V <sub>DS</sub> = 0 V	

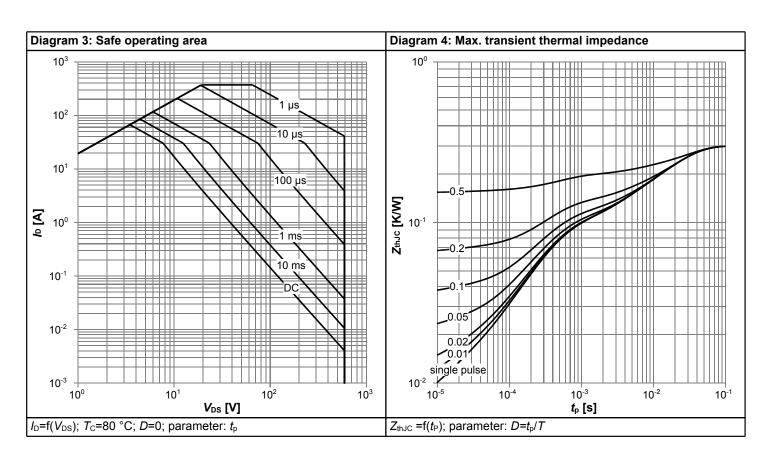
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Rev. 2.0, 2023-11-30

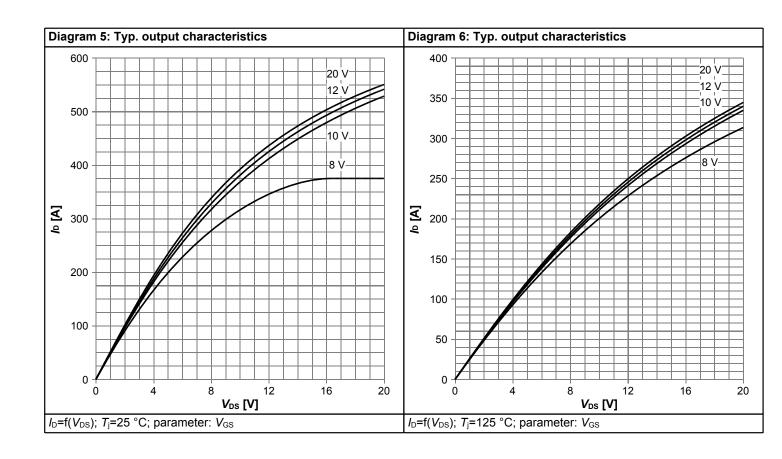


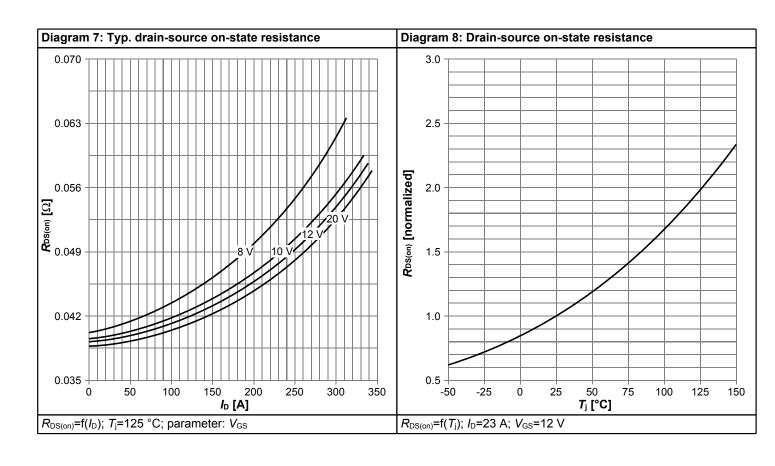
# 5 Electrical characteristics diagrams



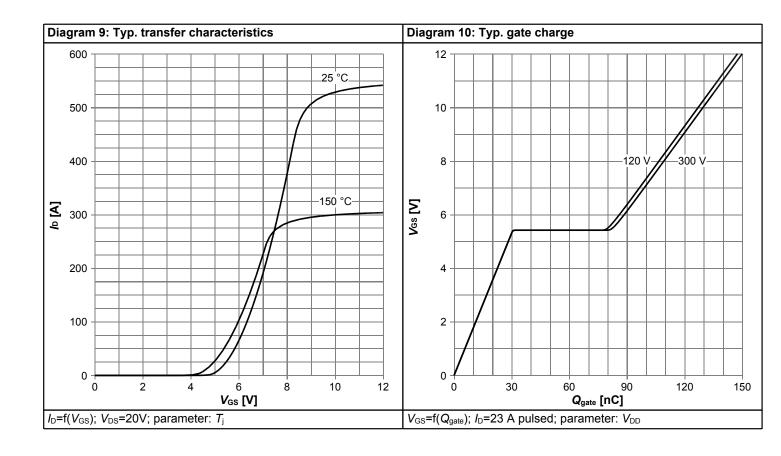


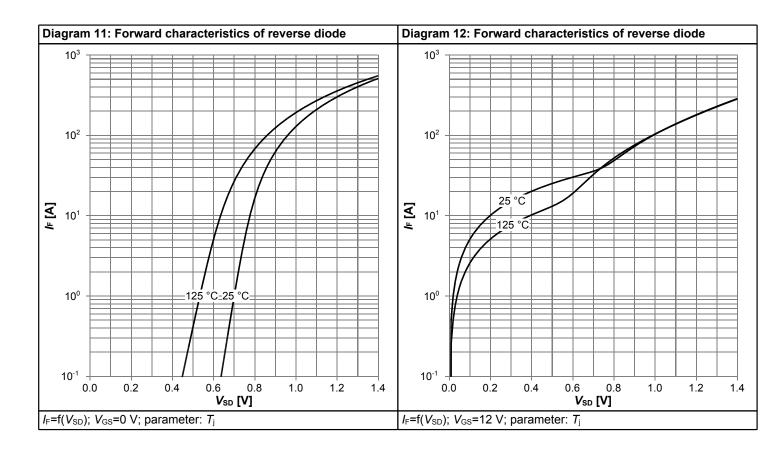




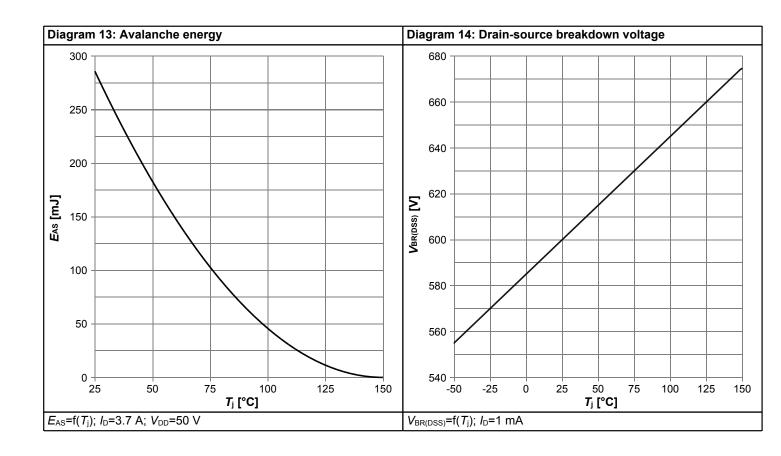


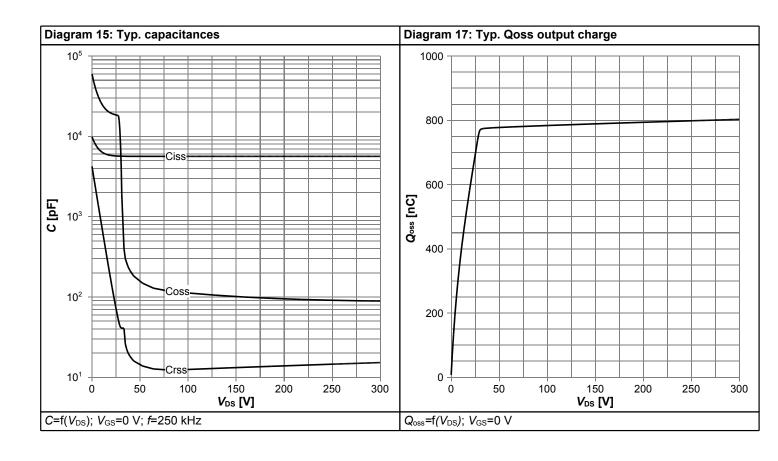




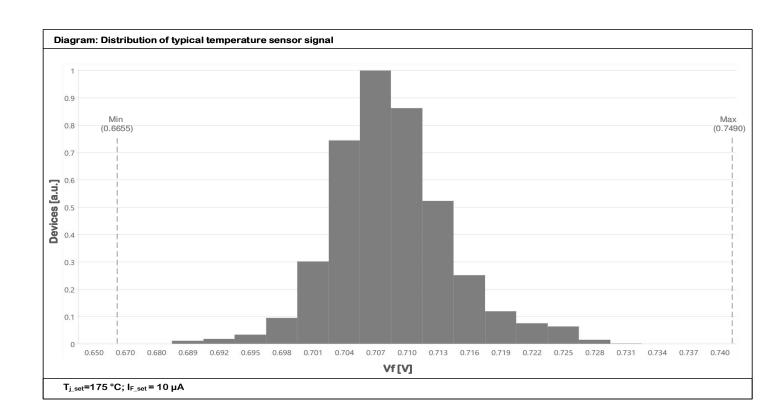














## 6 Test Circuits

Table 10 Diode characteristics

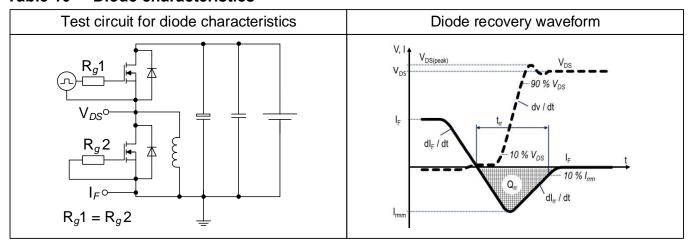


Table 11 Switching times (ss)

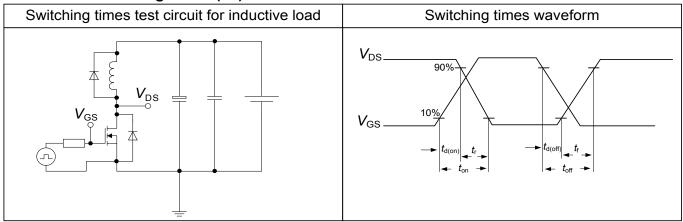
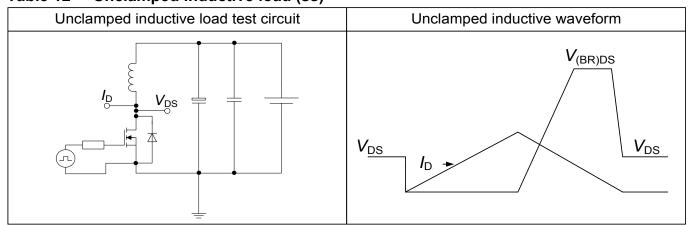


Table 12 Unclamped inductive load (ss)





# 7 Package Outlines

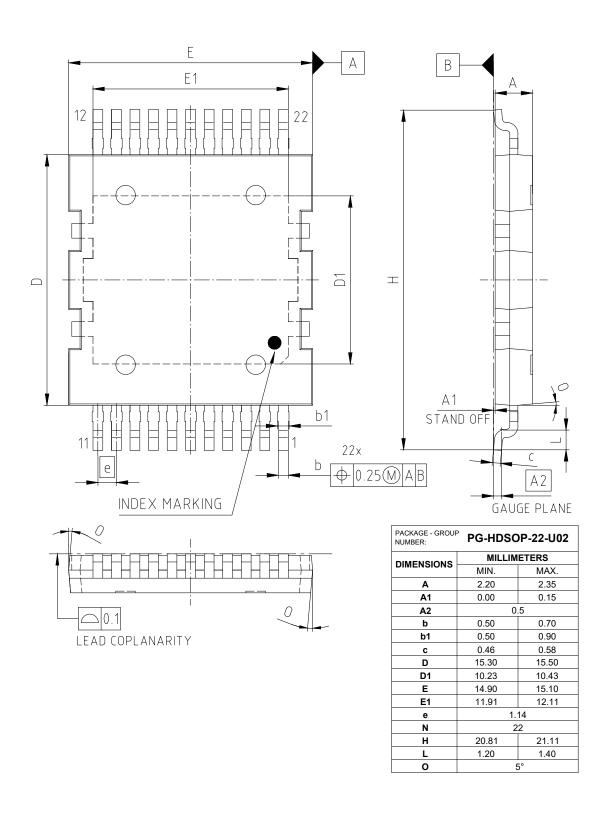


Figure 1 Outline PG-HDSOP-22, dimensions in mm

# 600V CoolMOS™ SJ S7TA Power Device IPQC60T022S7A



# 8 Appendix A

### Table 13 Related Links

• IFX CoolMOS™ S7TA Webpage: www.infineon.com

• IFX CoolMOS™ S7TA application note: www.infineon.com

• IFX CoolMOS™ S7TA simulation model: www.infineon.com

• IFX Design tools: www.infineon.com

# 600V CoolMOS™ SJ S7TA Power Device

#### IPQC60T022S7A



### **Revision History**

IPQC60T022S7A

Revision: 2023-11-30, Rev. 2.0

**Previous Revision** 

Revision	Date	Subjects (major changes since last revision)
2.0	2023-11-30	Release of final version

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